## Notice of References Cited Application/Control No. 10/600,850 Examiner Hai C. Pham U.S. PATENT DOCUMENTS Applicant(s)/Patent Under Reexamination ODA ET AL. Art Unit Page 1 of 1

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*	Α	US-6,181,356	01-2001	Ohnishi et al.	347/116
	В	US-			
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## **NON-PATENT DOCUMENTS**

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